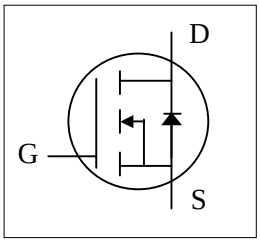
AP99T06AGI-HF

Halogen-Free Product

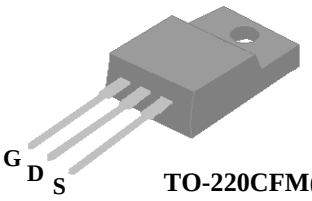
Advanced Power Electronics Corp.

N-CHANNEL ENHANCEMENT MODE POWER MOSFET

- ▼ **Simple Drive Requirement**
- ▼ **Low On-resistance**
- ▼ **Fast Switching Characteristic**
- ▼ **RoHS Compliant & Halogen-Free**



BV_{DSS}	60V
$R_{DS(ON)}$	4.2mΩ
I_D	76A



TO-220CFM(I)

Description

AP99T06A series are from Advanced Power innovated design and silicon process technology to achieve the lowest possible on-resistance and fast switching performance. It provides the designer with an extreme efficient device for use in a wide range of power applications.

The TO-220CFM package is widely preferred for all commercial-industrial through hole applications. The mold compound provides a high isolation voltage capability and low thermal resistance between the tab and the external heat-sink.

Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	60	V
V_{GS}	Gate-Source Voltage	±20	V
I_D@T_C=25℃	Continuous Drain Current, V_{GS} @ 10V	76	A
I_D@T_C=100℃	Continuous Drain Current, V_{GS} @ 10V	48	A
I_{DM}	Pulsed Drain Current[1]	300	A
P_D@T_C=25℃	Total Power Dissipation	44.6	W
P_D@T_A=25℃	Total Power Dissipation	1.92	W
T_{STG}	Storage Temperature Range	-55 to 150	℃
T_J	Operating Junction Temperature Range	-55 to 150	℃

Thermal Data

Symbol	Parameter	Value	Units
Rthj-c	Maximum Thermal Resistance, Junction-case	2.8	℃/W
Rthj-a	Maximum Thermal Resistance, Junction-ambient	65	℃/W

Electrical Characteristics@T_j=25°C(unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS}=0V, I_D=250uA	60	-	-	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance[2]	V_{GS}=10V, I_D=40A	-	-	4.2	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=V_{GS}, I_D=250uA	2	-	5	V
g_{fs}	Forward Transconductance	V_{DS}=10V, I_D=40A	-	70	-	S
I_{DSS}	Drain-Source Leakage Current	V_{DS}=48V, V_{GS}=0V	-	-	25	uA
I_{GSS}	Gate-Source Leakage	V_{GS}= ±20V, V_{DS}=0V	-	-	±100	nA
Q_g	Total Gate Charge	I_D=30A	-	110	175	nC
Q_{gs}	Gate-Source Charge	V_{DS}=48V	-	16	-	nC
Q_{gd}	Gate-Drain ("Miller") Charge	V_{GS}=10V	-	55	-	nC
$t_{d(on)}$	Turn-on Delay Time	V_{DS}=30V	-	18	-	ns
t_r	Rise Time	I_D=30A	-	57	-	ns
$t_{d(off)}$	Turn-off Delay Time	R_G=1Ω	-	40	-	ns
t_f	Fall Time	V_{GS}=10V	-	22	-	ns
C_{iss}	Input Capacitance	V_{GS}=0V	-	4300	6880	pF
C_{oss}	Output Capacitance	V_{DS}=25V	-	820	-	pF
C_{rss}	Reverse Transfer Capacitance	f=1.0MHz	-	510	-	pF
R_g	Gate Resistance	f=1.0MHz	-	1.1	2.2	Ω

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V_{SD}	Forward On Voltage[2]	I_S=40A, V_{GS}=0V	-	-	1.3	V
t_{rr}	Reverse Recovery Time	I_S=10A, V_{GS}=0V	-	56	-	ns
Q_{rr}	Reverse Recovery Charge	dI/dt=100A/μs	-	105	-	nC

Notes:

1.Pulse width limited by Max. junction temperature.

2.Pulse test

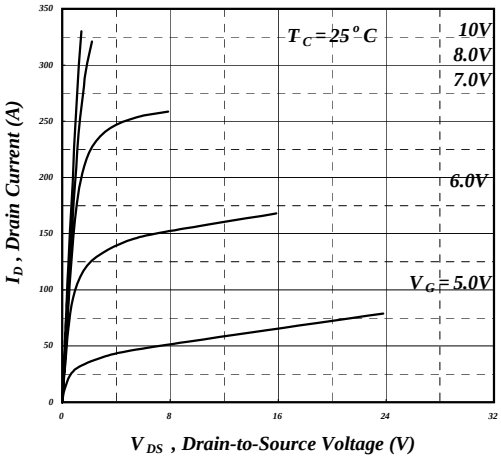


Fig 1. Typical Output Characteristics

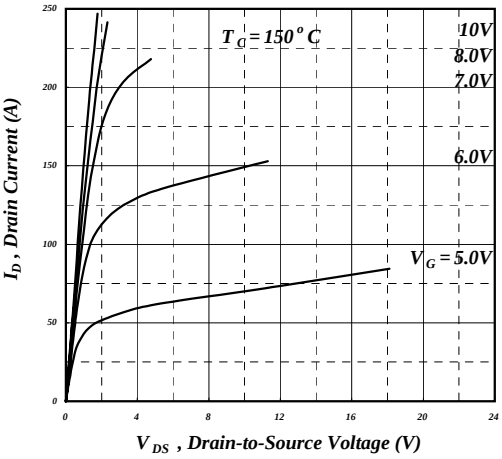


Fig 2. Typical Output Characteristics

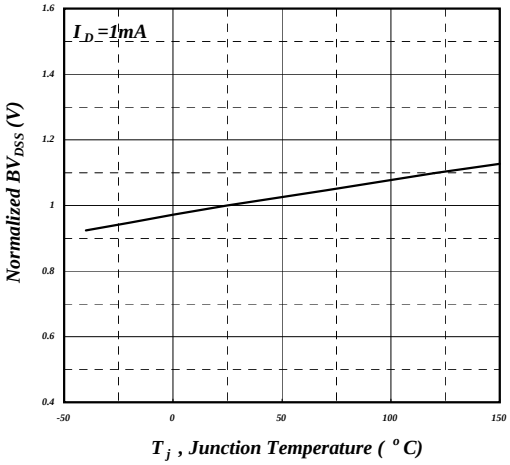


Fig 3. Normalized BV_{DSS} v.s. Junction Temperature

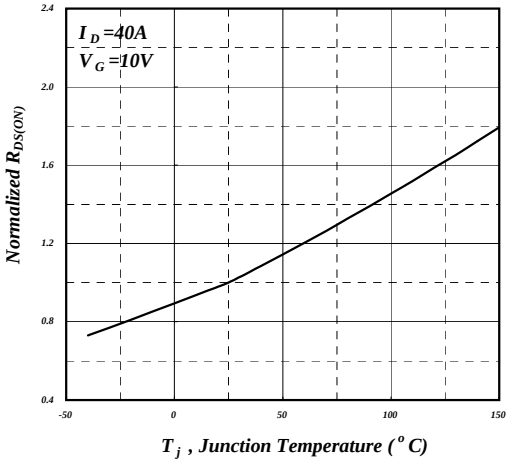


Fig 4. Normalized On-Resistance v.s. Junction Temperature

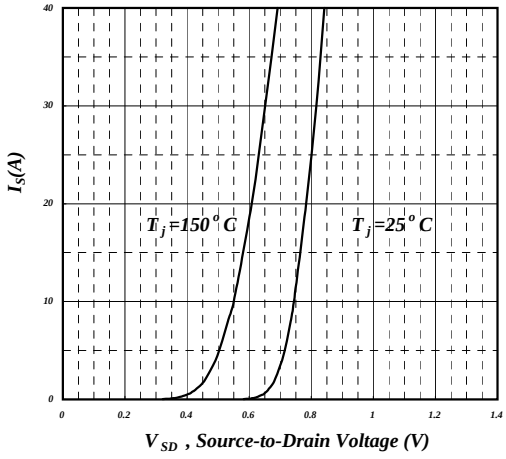


Fig 5. Forward Characteristic of Reverse Diode

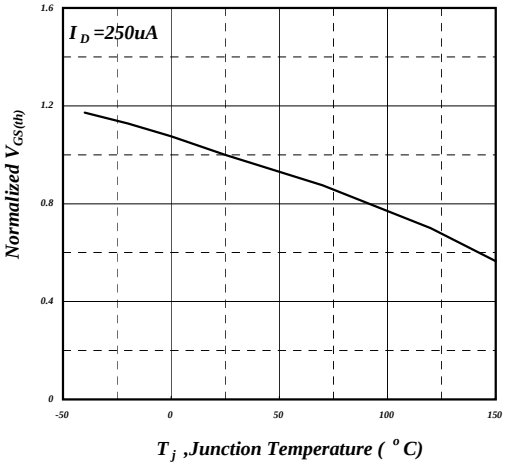


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

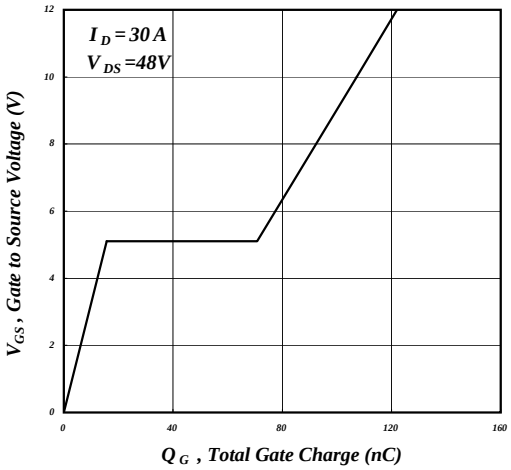


Fig 7. Gate Charge Characteristics

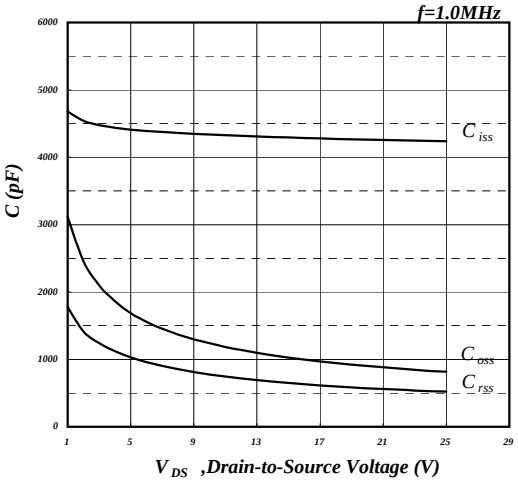


Fig 8. Typical Capacitance Characteristics

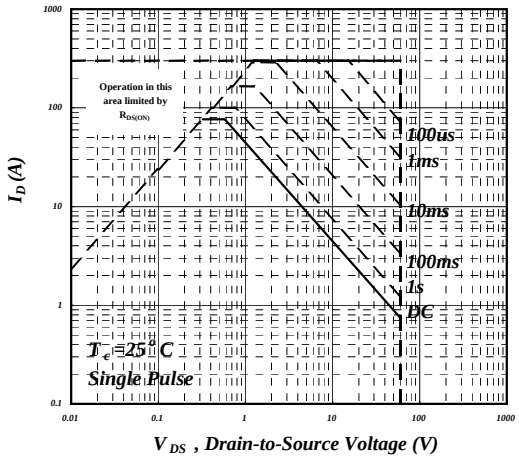


Fig 9. Maximum Safe Operating Area

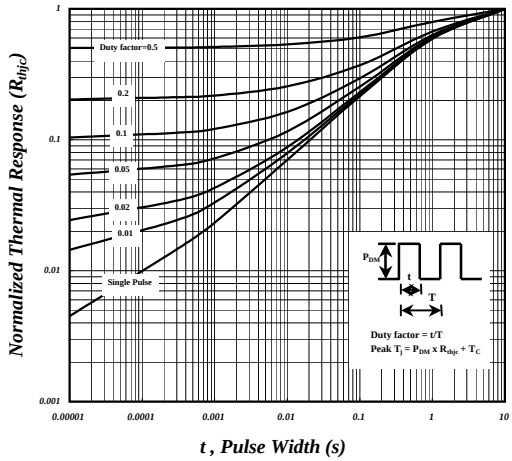


Fig 10. Effective Transient Thermal Impedance

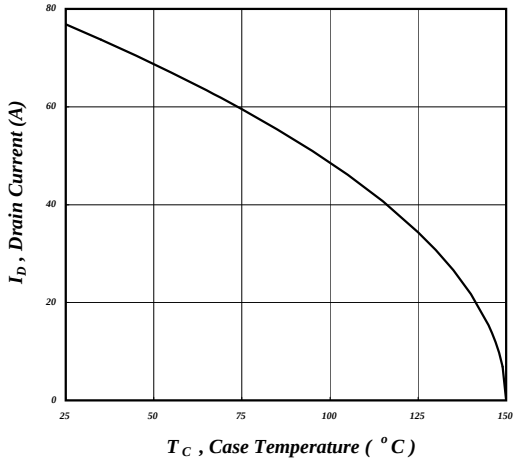


Fig 11. Maximum Continuous Drain Current v.s. Case Temperature

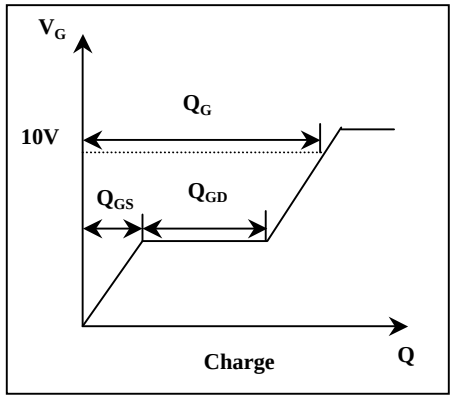


Fig 12. Gate Charge Waveform